


FORM PTO-1449 REV. (7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. 00-VR04.75CIP		SERIAL NO. 09/781,922	
LIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT(S): Doskow et al.			
				FILING DATE Feb. 5, 2001		GROUP	
				2616			
U.S. PATENT DOCUMENTS							
* EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)	
SH  	5,881,132	03/1999	O'Brien et al.				
	5,987,035	11/1999	Silva				
	6,014,427	01/2000	Hanson et al.				
	6,081,591	06/2000	Skoog <i>Jones et al.</i>				
	6,141,341	10/2000	<del>Cheeseman et al.</del>				
	6,226,289	05/2001	Williams et al.				
	6,226,372	05/2001	Beebe et al.				
	6,233,234	05/2001	Curry et al.				
	6,249,575	06/2001	Heilmann et al.				
	6,282,267	08/2001	Nolting				
	6,308,276	10/2001	Ashdown et al.				
	6,324,271	11/2001	Sawyer et al.				
	6,574,730	06/2003	Bissell et al.				
	6,647,113	11/2003	McCann et al.				
	6,687,353	02/2004	Brysch et al.				
	6,718,024	04/2004	Heilmann et al.				
	2002/0052200	05/2002	Arkko et al.				
	SH	2002/0071543	06/2002	Williams			
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)							
SH	Schneier, "Applied Crpytography", 1996, John Wiley, 2 <sup>nd</sup> Edition, pages 38, 576-577						
EXAMINER /Soon Hyun/				DATE CONSIDERED 11/30/2006			
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